# **BUK7905-40AIE**



# N-channel TrenchPLUS standard level FET

Rev. 05 — 10 February 2009

**Product data sheet** 

## 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS current sensing and diodes for ElectroStatic Discharge (ESD) protection. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

### 1.2 Features and benefits

- Electrostatically robust due to integrated protection diodes
- Low conduction losses due to low on-state resistance
- Q101 compliant

- Reduced component count due to integrated current sensor
- Suitable for standard level gate drive sources

## 1.3 Applications

Electrical Power Assisted Steering (EPAS) Variable Valve Timing for engines

#### 1.4 Quick reference data

Table 1. Quick reference

| Symbol                             | Parameter                               | Conditions  |            | Min | Тур | Max | Unit |
|------------------------------------|---|---|------------|-----|-----|-----|------|
| $V_{DS}$                           | drain-source voltage                    | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$   |            | -   | -   | 40  | V    |
| $I_D$                              | drain current                           | $V_{GS}$ = 10 V; $T_{mb}$ = 25 °C;<br>see <u>Figure 2</u> ; see <u>Figure 3</u> ;   | <u>[1]</u> | -   | -   | 155 | Α    |
| Static ch                          | naracteristics                          |   |            |     |     |     |      |
| R <sub>DSon</sub>                  | drain-source<br>on-state resistance     | $V_{GS} = 10 \text{ V; } I_D = 50 \text{ A;}$<br>$T_j = 25 \text{ °C; see } \frac{\text{Figure 7; see}}{\text{Figure 8}}$ |            | -   | 4.5 | 5   | mΩ   |
| I <sub>D</sub> /I <sub>sense</sub> | ratio of drain current to sense current | $T_j > -55 ^{\circ}\text{C}; T_j < 175 ^{\circ}\text{C};$<br>$V_{GS} > 10 ^{\circ}\text{V}$                               |            | 450 | 500 | 550 |      |

<sup>[1]</sup> Current is limited by power dissipation chip rating.



# 2. Pinning information

**Table 2. Pinning information** 

| Pin | Symbol | Description                       | Simplified outline               | Graphic symbol                          |
|-----|--------|-----------------------------------|----------------------------------|---|
| 1   | G      | gate                              |                                  | d                                       |
| 2   | ISENSE | Sense current                     | mb                               |   |
| 3   | D      | drain                             |                                  |   |
| 4   | KS     | Kelvin source                     |                                  |   |
| 5   | S      | source                            |                                  | 9 \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ |
| mb  | D      | mounting base; connected to drain | 1 2 3 4 5<br>SOT263B<br>(TO-220) | MBL368 Sense Kelvin source              |

# 3. Ordering information

Table 3. Ordering information

| Type number   | Package |  |         |
|---------------|---------|--|---------|
|               | Name    | Description  | Version |
| BUK7905-40AIE | TO-220  | plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220 | SOT263B |

# 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol               | Parameter  | Conditions   |     | Min | Max  | Unit |
|----------------------|--|--|-----|-----|------|------|
| $V_{DS}$             | drain-source voltage                               | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  |     | -   | 40   | V    |
| $V_{DGR}$            | drain-gate voltage                                 | $R_{GS} = 20 \text{ k}\Omega$  |     | -   | 40   | V    |
| $V_{GS}$             | gate-source voltage                                |  |     | -20 | 20   | V    |
| $I_D$                | drain current                                      | T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u> ; see <u>Figure 3</u>                   | [1] | -   | 155  | Α    |
|                      |  |  |     | -   | 75   | Α    |
|                      |  | T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 2</u>  | [2] | -   | 75   | Α    |
| $I_{DM}$             | peak drain current                                 | $T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see Figure 3  |     | -   | 620  | Α    |
| P <sub>tot</sub>     | total power dissipation                            | T <sub>mb</sub> = 25 °C; see <u>Figure 1</u>   |     | -   | 272  | W    |
| I <sub>GS(CL)</sub>  | gate-source clamping                               | continuous   |     | -   | 10   | mΑ   |
|                      | current  | pulsed; $t_p = 5$ ms; $\delta = 0.01$  |     | -   | 50   | mA   |
| T <sub>stg</sub>     | storage temperature                                |  |     | -55 | 175  | °C   |
| Tj                   | junction temperature                               |  |     | -55 | 175  | °C   |
| Source-dra           | ain diode  |  |     |     |      |      |
| Is                   | source current                                     | $T_{mb} = 25  ^{\circ}C$   | [1] | -   | 155  | Α    |
|                      |  |  | [2] | -   | 75   | Α    |
| I <sub>SM</sub>      | peak source current                                | $t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$   |     | -   | 620  | Α    |
| Avalance r           | uggedness  |  |     |     |      |      |
| E <sub>DS(AL)S</sub> | non-repetitive<br>drain-source avalanche<br>energy | $I_D$ = 75 A; $V_{sup} \le 40$ V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped |     | -   | 1.46 | J    |
| Electrosta           | tic discharge                                      |  |     |     |      |      |
| V <sub>esd</sub>     | electrostatic discharge voltage                    | HBM; C = 100 pF; R = 1.5 kΩ  |     | -   | 6    | kV   |
|                      |  |  |     |     |      |      |

<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

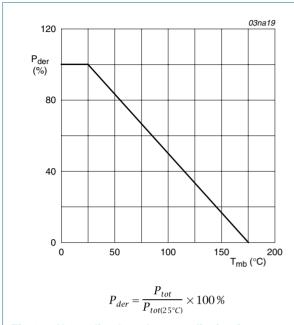


Fig 1. Normalized total power dissipation as a function of mounting base temperature

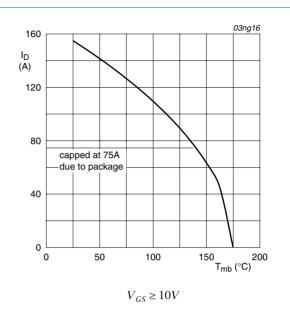


Fig 2. Continuous drain current as a function of mounting base temperature

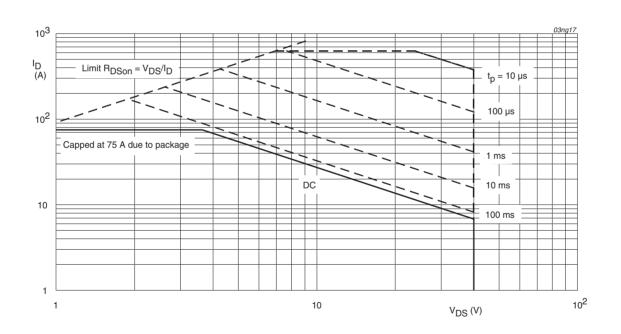


Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 $T_{mb} = 25$ °C; $I_{DM}$ is single pulse

## 5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol                | Parameter   | Conditions            | Min | Тур | Max  | Unit |
|-----------------------|---|-----------------------|-----|-----|------|------|
| $R_{th(j-a)}$         | thermal resistance from junction to ambient       | vertical in still air | -   | 60  | -    | K/W  |
| R <sub>th(j-mb)</sub> | thermal resistance from junction to mounting base | see Figure 4          | -   | -   | 0.55 | K/W  |

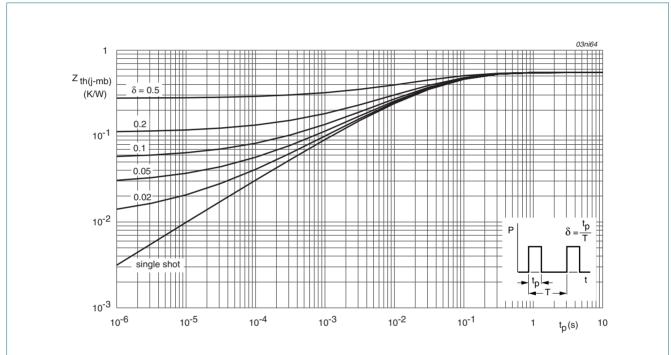


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

# 6. Characteristics

Table 6. Characteristics

| Table 6. C                         | Characteristics                         |  |      |      |      |      |
|------------------------------------|---|--|------|------|------|------|
| Symbol                             | Parameter                               | Conditions   | Min  | Тур  | Max  | Unit |
| Static chara                       | cteristics                              |  |      |      |      |      |
| $V_{(BR)DSS}$                      | drain-source                            | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$   | 40   | -    | -    | V    |
|                                    | breakdown voltage                       | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$  | 36   | -    | -    | V    |
| $V_{GS(th)}$                       | gate-source threshold voltage           | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 9</u>   | 2    | 3    | 4    | V    |
|                                    |   | $I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = 175 \text{ °C}$ ; see Figure 9                                     | 1    | -    | -    | V    |
|                                    |   | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 9   | -    | -    | 4.4  | V    |
| I <sub>DSS</sub>                   | drain leakage current                   | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$   | -    | 0.1  | 10   | μΑ   |
|                                    |   | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$  | -    | -    | 250  | μΑ   |
| $V_{(BR)GSS}$                      | gate-source breakdown voltage           | $I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j < 175 °C;$<br>$T_j > -55 °C$  | 20   | 22   | -    | V    |
|                                    |   | $I_G$ = -1 mA; $V_{DS}$ = 0 V; $T_j$ < 175 °C; $T_j$ > -55 °C  | 20   | 22   | -    | V    |
| I <sub>GSS</sub>                   | gate leakage current                    | V <sub>DS</sub> = 0 V; V <sub>GS</sub> = 10 V; T <sub>j</sub> = 25 °C  | -    | 22   | 1000 | nA   |
|                                    |   | $V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$  | -    | 22   | 1000 | nA   |
|                                    |   | $V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 175 \text{ °C}$  | -    | -    | 10   | μΑ   |
|                                    |   | $V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 175 \text{ °C}$   | -    | -    | 10   | μΑ   |
| R <sub>DSon</sub>                  | drain-source on-state resistance        | $V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 ^{\circ}\text{C};$<br>see <u>Figure 7</u> ; see <u>Figure 8</u> | -    | 4.5  | 5    | mΩ   |
|                                    |   | $V_{GS} = 10 \text{ V}$ ; $I_D = 50 \text{ A}$ ; $T_j = 175 \text{ °C}$ ; see Figure 7; see Figure 8                 | -    | -    | 9.5  | mΩ   |
| R <sub>(D-ISENSE)on</sub>          | drain-ISENSE on-state resistance        | $V_{GS} = 10 \text{ V}; I_D = 100 \text{ mA}; T_j = 25 \text{ °C};$ see Figure 16                                    | 0.98 | 1.08 | 1.18 | Ω    |
|                                    |   | $V_{GS} = 10 \text{ V}; I_D = 100 \text{ mA}; T_j = 175 ^{\circ}\text{C};$ see Figure 16                             | 1.86 | 2.05 | 2.24 | Ω    |
| I <sub>D</sub> /I <sub>sense</sub> | ratio of drain current to sense current | $V_{GS} > 10 \text{ V}; T_j > -55 \text{ °C}; T_j < 175 \text{ °C}$  | 450  | 500  | 550  |      |
| Dynamic ch                         | aracteristics                           |  |      |      |      |      |
| Q <sub>G(tot)</sub>                | total gate charge                       | $I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$  | -    | 120  | 127  | nC   |
| $Q_{GS}$                           | gate-source charge                      | T <sub>j</sub> = 25 °C; see <u>Figure 14</u>   | -    | 19   | 22   | nC   |
| $Q_{GD}$                           | gate-drain charge                       |  | -    | 50   | 60   | nC   |
| C <sub>iss</sub>                   | input capacitance                       | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$  | -    | 4300 | 5000 | pF   |
| C <sub>oss</sub>                   | output capacitance                      | T <sub>j</sub> = 25 °C; see <u>Figure 12</u>   | -    | 1400 | 1670 | pF   |
| C <sub>rss</sub>                   | reverse transfer capacitance            |  | -    | 820  | 1100 | pF   |
| t <sub>d(on)</sub>                 | turn-on delay time                      | $V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$  | -    | 35   | -    | ns   |
| t <sub>r</sub>                     | rise time                               | $R_{G(ext)} = 10 \Omega; T_j = 25 °C$  | -    | 115  | -    | ns   |
| t <sub>d(off)</sub>                | turn-off delay time                     |  | -    | 155  | -    | ns   |
| t <sub>f</sub>                     | fall time                               |  | -    | 110  | -    | ns   |
|                                    |   |  |      |      |      |      |

### N-channel TrenchPLUS standard level FET

Table 6. Characteristics ... continued

| Symbol          | Parameter                  | Conditions   | Min | Тур  | Max | Unit |
|-----------------|----------------------------|--|-----|------|-----|------|
| L <sub>D</sub>  | internal drain inductance  | from upper edge of drain mounting base to centre of die; $T_j = 25$ °C                     | -   | 2.5  | -   | nΗ   |
| L <sub>S</sub>  | internal source inductance | from source lead to source bond pad;<br>$T_j = 25  ^{\circ}\text{C}$                       | -   | 7.5  | -   | nΗ   |
| Source-dra      | ain diode                  |  |     |      |     |      |
| $V_{SD}$        | source-drain voltage       | $I_S = 40 \text{ A}$ ; $V_{GS} = 0 \text{ V}$ ; $T_j = 25 \text{ °C}$ ; see Figure 17      | -   | 0.85 | 1.2 | V    |
| t <sub>rr</sub> | reverse recovery time      | $I_S = 20 \text{ A}$ ; $dI_S/dt = -100 \text{ A/}\mu\text{s}$ ; $V_{GS} = -10 \text{ V}$ ; | -   | 96   | -   | ns   |
| Q <sub>r</sub>  | recovered charge           | $V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$   | -   | 224  | -   | nC   |

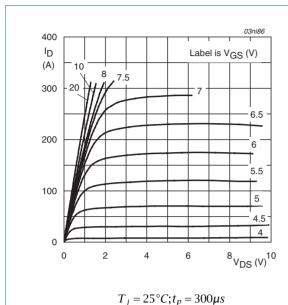
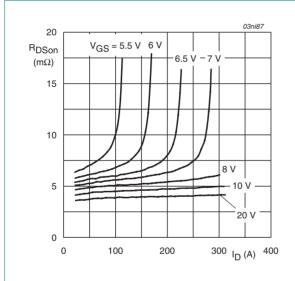
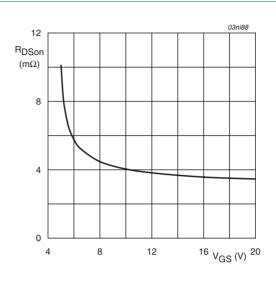


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

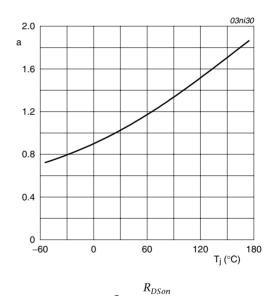


 $T_j=25\,^{\circ}C; t_p=300\mu s$  Fig 7. Drain-source on-state resistance as a function of drain current; typical values



 $T_j = 25^{\circ}C; I_D = 50A$ 

Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values



factor as a function of junction temperature

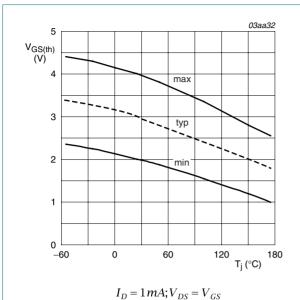
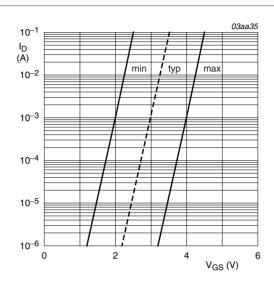
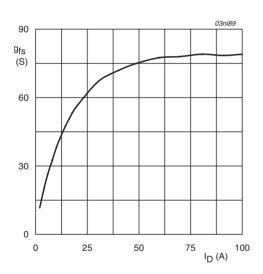


Fig 9. Gate-source threshold voltage as a function of junction temperature



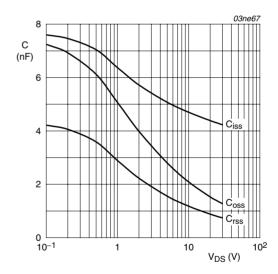
 $T_{j} = 25 \,^{\circ}C; V_{DS} = 5V$ 

Fig 10. Sub-threshold drain current as a function of gate-source voltage



 $T_i = 25$ °C;  $V_{DS} = 25V$ 

Fig 11. Forward transconductance as a function of drain current; typical values



 $V_{GS} = 0V; f = 1MHz$ 

Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

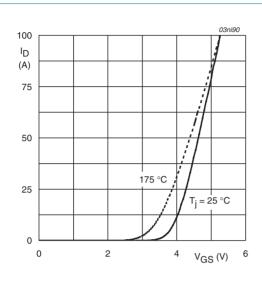
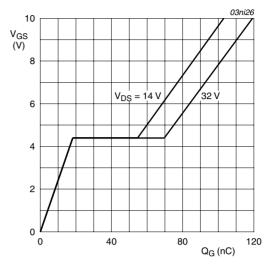


Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values

 $V_{DS} = 25V$ 



 $T_{j} = 25^{\circ}C; I_{D} = 25A$ 

Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values

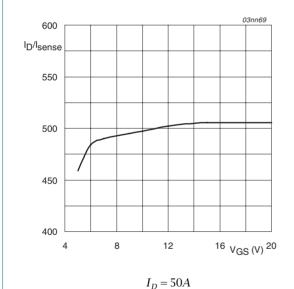
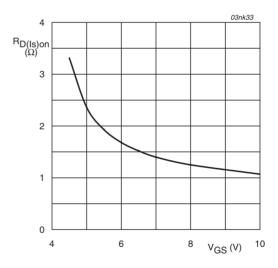
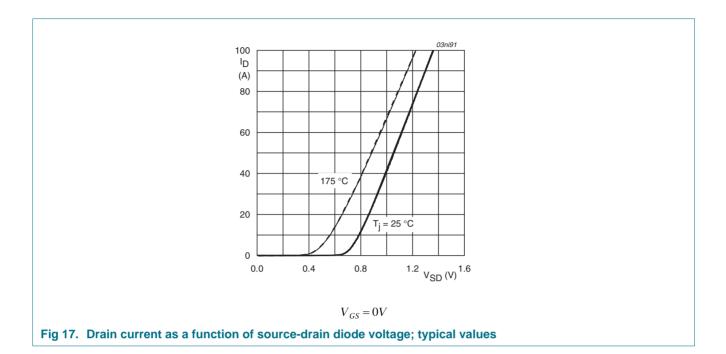


Fig 15. Drain-sense current ratio as a function of gate-source voltage; typical values



 $I_{sense} = 25mA$ 

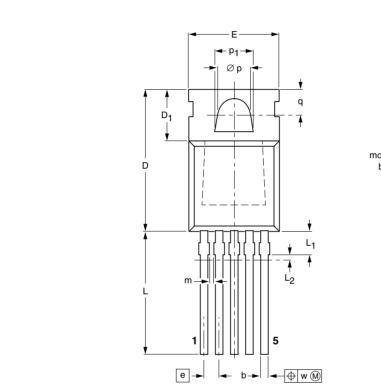
Fig 16. Drain-sense current on-state resistance as a function of gate-source voltage; typical values

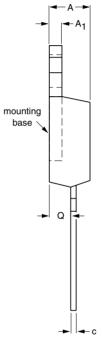


# 7. Package outline

### Plastic single-ended package; heatsink mounted; 1 mounting hole; 5-lead TO-220

SOT263B





0 5 10 mm

#### **DIMENSIONS (mm are the original dimensions)**

| UNIT | A          | A <sub>1</sub> | b            | С          | D            | D <sub>1</sub> | E           | е   | L            | L <sub>1</sub> <sup>(1)</sup> | L <sub>2</sub> <sup>(2)</sup> | m          | ∅p         | P <sub>1</sub> | q          | Q          | w   |
|------|------------|----------------|--------------|------------|--------------|----------------|-------------|-----|--------------|-------------------------------|-------------------------------|------------|------------|----------------|------------|------------|-----|
| mm   | 4.5<br>4.1 | 1.39<br>1.27   | 0.85<br>0.70 | 0.7<br>0.4 | 15.8<br>15.2 | 6.4<br>5.9     | 10.3<br>9.7 | 1.7 | 15.0<br>13.5 | 2.4<br>1.6                    | 0.5                           | 0.8<br>0.6 | 3.8<br>3.6 | 4.3<br>4.1     | 3.0<br>2.7 | 2.6<br>2.2 | 0.4 |

#### Notes

- 1. Terminal dimensions are uncontrolled in this zone.
- 2. Positional accuracy of the terminals is controlled in this zone.

| OUTLINE |         |     | REFER         | ENCES | EUROPEAN ISSUE DA |            |            |  |  |
|---------|---------|-----|---------------|-------|-------------------|------------|------------|--|--|
|         | VERSION | IEC | JEDEC         | EIAJ  |                   | PROJECTION | ISSUE DATE |  |  |
|         | SOT263B |     | 5-lead TO-220 |       |                   |            | 01-01-11   |  |  |

Fig 18. Package outline SOT263B (TO-220)

# 8. Revision history

### Table 7. Revision history

|                     | •                               |  |                         |                       |
|---------------------|---------------------------------|--|-------------------------|-----------------------|
| Document ID         | Release date                    | Data sheet status                                  | Change notice           | Supersedes            |
| BUK7905-40AIE_5     | 20090210                        | Product data sheet                                 | -                       | BUK71_7905_40AIE-04   |
| Modifications:      |                                 | of this data sheet has been of NXP Semiconductors. | n redesigned to comply  | with the new identity |
|                     | <ul> <li>Legal texts</li> </ul> | have been adapted to the                           | new company name wh     | nere appropriate.     |
|                     | <ul> <li>Type numb</li> </ul>   | er BUK7905-40AIE separa                            | ated from data sheet BU | K71_7905_40AIE-04.    |
| BUK71_7905_40AIE-04 | 20040206                        | Product data                                       | -                       | BUK71_7905_40AIE-03   |
| BUK71_7905_40AIE-03 | 20030523                        | Product data                                       | -                       | BUK71_7905_40AIE-02   |
| BUK71_7905_40AIE-02 | 20021001                        | Product data                                       | -                       | BUK71_7905_40AIE-01   |
| BUK71_7905_40AIE-01 | 20020725                        | Product data                                       | -                       | -                     |
|                     |                                 |  |                         |                       |

## 9. Legal information

#### 9.1 Data sheet status

| Document status [1][2]         | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nexperia.com.

### 9.2 Definitions

**Draft** — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. Nexperia does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local Nexperia sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

#### 9.3 Disclaimers

**General** — Information in this document is believed to be accurate and reliable. However, Nexperia does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

Right to make changes — Nexperia reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — Nexperia products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of a Nexperia product can reasonably be expected to result in personal injury, death or severe property or environmental damage. Nexperia accepts no liability for inclusion and/or use of Nexperia products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. Nexperia makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

**Quick reference data** — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — Nexperia products are sold subject to the general terms and conditions of commercial sale, as published at <a href="http://www.nexperia.com/profile/terms">http://www.nexperia.com/profile/terms</a>, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by Nexperia. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

**No offer to sell or license** — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

#### 9.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

## 10. Contact information

For more information, please visit: http://www.nexperia.com

For sales office addresses, please send an email to: salesaddresses@nexperia.com

# **BUK7905-40AIE**

### N-channel TrenchPLUS standard level FET

# 11. Contents

| 1   | Product profile          |
|-----|--------------------------|
| 1.1 | General description      |
| 1.2 | Features and benefits1   |
| 1.3 | Applications1            |
| 1.4 | Quick reference data1    |
| 2   | Pinning information      |
| 3   | Ordering information2    |
| 4   | Limiting values3         |
| 5   | Thermal characteristics5 |
| 6   | Characteristics6         |
| 7   | Package outline          |
| 8   | Revision history13       |
| 9   | Legal information14      |
| 9.1 | Data sheet status        |
| 9.2 | Definitions              |
| 9.3 | Disclaimers              |
| 9.4 | Trademarks14             |
| 10  | Contact information      |

# **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by NXP manufacturer:

Other Similar products are found below:

614233C 648584F MCH3443-TL-E MCH6422-TL-E FDPF9N50NZ FW216A-TL-2W FW231A-TL-E APT5010JVR NTNS3A92PZT5G IRF100S201 JANTX2N5237 2SK2464-TL-E 2SK3818-DL-E FCA20N60\_F109 FDZ595PZ STD6600NT4G FSS804-TL-E 2SJ277-DL-E 2SK1691-DL-E 2SK2545(Q,T) D2294UK 405094E 423220D MCH6646-TL-E TPCC8103,L1Q(CM 367-8430-0972-503 VN1206L 424134F 026935X 051075F SBVS138LT1G 614234A 715780A NTNS3166NZT5G 751625C 873612G IRF7380TRHR IPS70R2K0CEAKMA1 RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3